## Applicant(s)/Patent Under Application/Control No. ø: (a þ Reexamination 09/779,397 TODD, MICHAEL A. Notice of References Cited Art Unit Examiner Page 1 of 1 B. Chen 1762 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,303,047 10-2001 Aronowitz et al. 252/1 US-6,258,407 07-2001 В Lee et al. 427/255.28 US-6,245,690 06-2001 Yau et al. 438/780 C US-6,004,730 12-1999 Mikoshiba et al. D 430/325 Ε US-6,340,628 01-2002 Van Cleemput et al. 438/586 F US-6,458,718 10-2002 Todd, Michael A. 438/778 US-G US-Н US-Į US-J US-Κ US-L US-Μ FOREIGN PATENT DOCUMENTS Document Number Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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